

Application/Control No.	Applicant(s)/Patent under Reexamination
09/870,115	CHEN, YONG S.
Examiner	Art Unit
MONZED D. CHODDA II	1744

SEARCHED					
Class	Subclass	Date	Examiner		
422	1,5,28,120 ,125- 126,305- 307	12/9/2005	MRC		
237	78R	12/9/2005	MRC		
392	390-393	12/9/2005	MRC		
219	429-430	12/9/2005	MRC		
219	433,438	12/9/2005	MRC		
219	441	12/9/2005	MRC		
126	350B	12/9/2005	MRC		
126	345	12/9/2005	MRC		
122	493,510	12/9/2005	MRC		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PGPUB, USPAT, EPO, JPO, DERWENT, IBM_TDB, USOCR).	12/9/2005	MRC		
Conducted inventor name search.	12/9/2005	MRC		
422/1,5,28,120,125-126,305-307 (text seach only - see search history printout).	12/9/2005	MRC		
237/ 78R: 392/ 390-393(text seach only - see search history printout).	12/9/2005	MRC		
219/429-430,433,438,441 (text seach only - see search history printout).	12/9/2005	MRC		
126/350B, 345: 122/493, 510 (text seach only - see search history printout).	12/9/2005	MRC		
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